


<b>Search Notes</b>  	<b>Application/Control No.</b>  10519564	<b>Applicant(s)/Patent Under Reexamination</b>  SAITO, TAKESHI
	<b>Examiner</b>  Chen, Junpeng	<b>Art Unit</b>  2618

SEARCHED			
Class	Subclass	Date	Examiner
455	88,108,98,69,556.1,344,557,572	04/12/2007	J.C.
340	10.1-10.3,572.4,10.5	04/12/2007	J.C.
342	44,193	04/12/2007	J.C.
375	300,268	04/12/2007	J.C.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Image and keyword search in USPAT, US-PG Pub, DERWENT, EPO, JPO and IBM_TDB	12/05/2006	J.C.
Consulted with Edan, Orgad, Quochien Young on Claim 10	12/15/2006	J.C.
Consulted with Lewis West	12/15/2006	J.C.
Consulted with Edan Orgad	04/12/2007	J.C.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
455	88,108,98,69,556.1,344,557,572	04/12/2007	J.C.
340	10.1-10.3,572.4,10.5	04/12/2007	J.C.
342	44,193	04/12/2007	J.C.
375	300,268	04/12/2007	J.C.